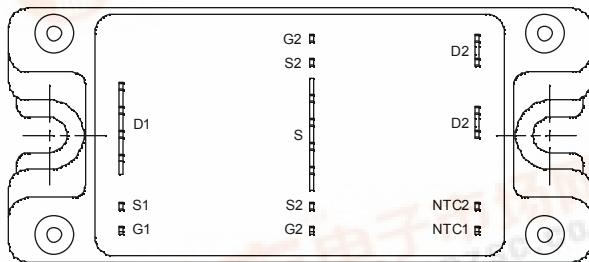
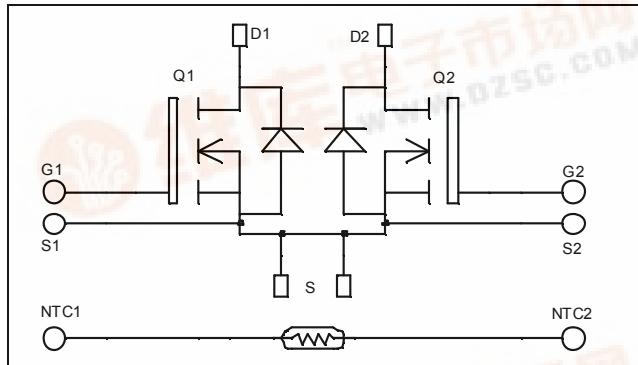




# APTM120DU29TG

## Dual Common Source MOSFET Power Module

$V_{DSS} = 1200V$   
 $R_{DSon} = 290m\Omega$  typ @  $T_j = 25^\circ C$   
 $I_D = 34A$  @  $T_c = 25^\circ C$



### Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
$V_{DSS}$	Drain - Source Breakdown Voltage	1200	V
$I_D$	Continuous Drain Current	$T_c = 25^\circ C$	A
		$T_c = 80^\circ C$	
$I_{DM}$	Pulsed Drain current	136	
$V_{GS}$	Gate - Source Voltage	$\pm 30$	V
$R_{DSon}$	Drain - Source ON Resistance	348	$m\Omega$
$P_D$	Maximum Power Dissipation	$T_c = 25^\circ C$	W
$I_{AR}$	Avalanche current (repetitive and non repetitive)	22	A
$E_{AR}$	Repetitive Avalanche Energy	50	
$E_{AS}$	Single Pulse Avalanche Energy	3000	$mJ$



**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handing Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



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All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified

### Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0\text{V}, V_{DS} = 1200\text{V}$	$T_j = 25^\circ\text{C}$		350	$\mu\text{A}$
		$V_{GS} = 0\text{V}, V_{DS} = 1000\text{V}$	$T_j = 125^\circ\text{C}$		1500	
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10\text{V}, I_D = 17\text{A}$		290	348	$\text{m}\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 5\text{mA}$	3		5	$\text{V}$
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 30\text{ V}, V_{DS} = 0\text{V}$			$\pm 150$	$\text{nA}$

### Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0\text{V}$ $V_{DS} = 25\text{V}$ $f = 1\text{MHz}$		10.3		$\text{nF}$
$C_{oss}$	Output Capacitance			1.54		
$C_{rss}$	Reverse Transfer Capacitance			0.26		
$Q_g$	Total gate Charge	$V_{GS} = 10\text{V}$ $V_{Bus} = 600\text{V}$ $I_D = 34\text{A}$		374		$\text{nC}$
$Q_{gs}$	Gate – Source Charge			48		
$Q_{gd}$	Gate – Drain Charge			240		
$T_{d(on)}$	Turn-on Delay Time	<b>Inductive switching @ 125°C</b> $V_{GS} = 15\text{V}$ $V_{Bus} = 800\text{V}$ $I_D = 34\text{A}$		20		$\text{ns}$
$T_r$	Rise Time			15		
$T_{d(off)}$	Turn-off Delay Time			160		
$T_f$	Fall Time			45		
$E_{on}$	Turn-on Switching Energy	<b>Inductive switching @ 25°C</b> $V_{GS} = 15\text{V}, V_{Bus} = 800\text{V}$ $I_D = 34\text{A}, R_G = 2.5\Omega$		1980		$\mu\text{J}$
$E_{off}$	Turn-off Switching Energy			1371		
$E_{on}$	Turn-on Switching Energy	<b>Inductive switching @ 125°C</b> $V_{GS} = 15\text{V}, V_{Bus} = 800\text{V}$ $I_D = 34\text{A}, R_G = 2.5\Omega$		3131		$\mu\text{J}$
$E_{off}$	Turn-off Switching Energy			1714		

### Source - Drain diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_S$	Continuous Source current (Body diode)		$T_c = 25^\circ\text{C}$		34	$\text{A}$
			$T_c = 80^\circ\text{C}$		25	
$V_{SD}$	Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = - 34\text{A}$			1.3	$\text{V}$
$dv/dt$	Peak Diode Recovery $\bullet$				10	$\text{V/ns}$
$t_{rr}$	Reverse Recovery Time	$I_S = - 34\text{A} ; V_R = 600\text{V}$ $dI/dt = 200\text{A}/\mu\text{s}$		1291		$\text{ns}$
$Q_{rr}$	Reverse Recovery Charge			58		$\mu\text{C}$

$\bullet$  dv/dt numbers reflect the limitations of the circuit rather than the device itself.

$I_S \leq - 34\text{A}$     $di/dt \leq 700\text{A}/\mu\text{s}$     $V_R \leq V_{DSS}$     $T_j \leq 150^\circ\text{C}$



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### Thermal and package characteristics

Symbol	Characteristic		Min	Typ	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.16	°C/W
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, I isol<1mA, 50/60Hz	2500				V
T <sub>J</sub>	Operating junction temperature range	-40		150		
T <sub>STG</sub>	Storage Temperature Range	-40		125		°C
T <sub>C</sub>	Operating Case Temperature	-40		100		
Torque	Mounting torque	To Heatsink	M5	2.5	4.7	N.m
Wt	Package Weight				160	g

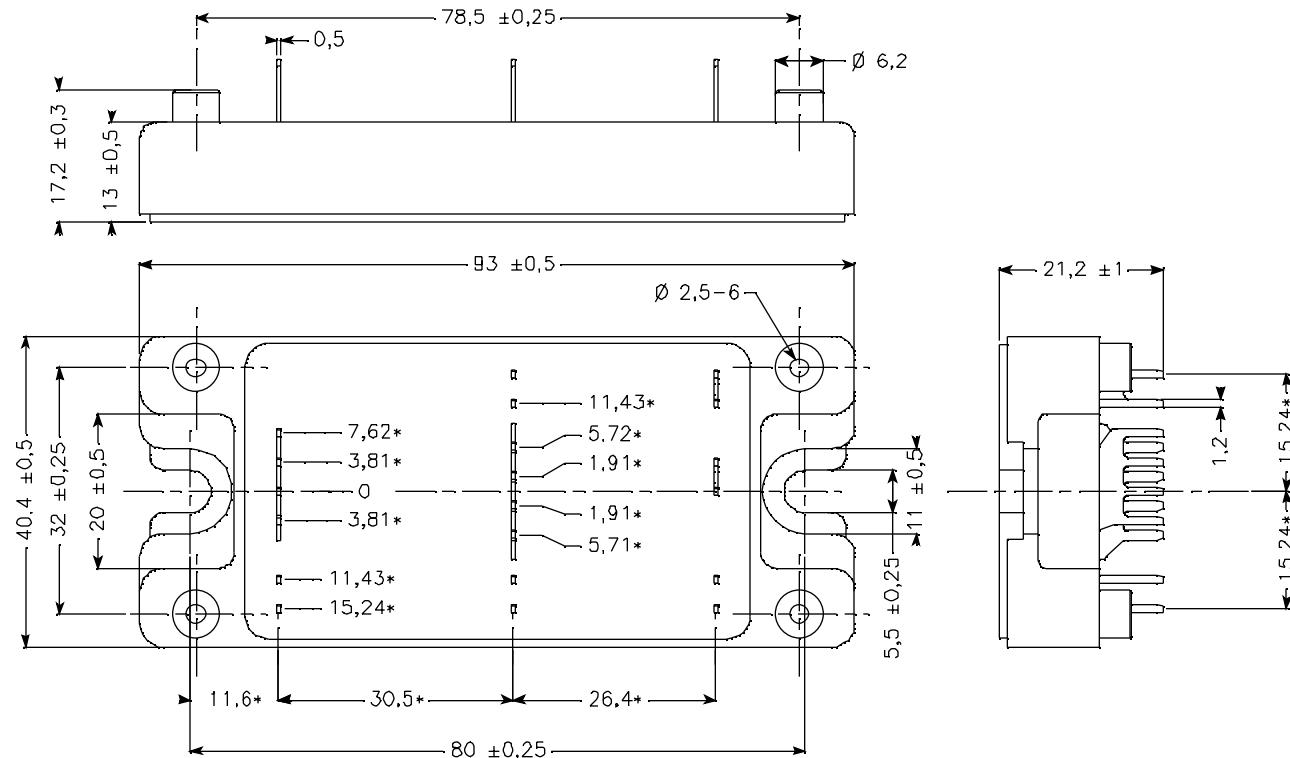
**Temperature sensor NTC** (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic		Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
B <sub>25/85</sub>	T <sub>25</sub> = 298.15 K			3952		K

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

### SP4 Package outline (dimensions in mm)



ALL DIMENSIONS MARKED " \* " ARE TOLERENCED AS :

See application note APT0501 - Mounting Instructions for SP4 Power Modules on [www.microsemi.com](http://www.microsemi.com)

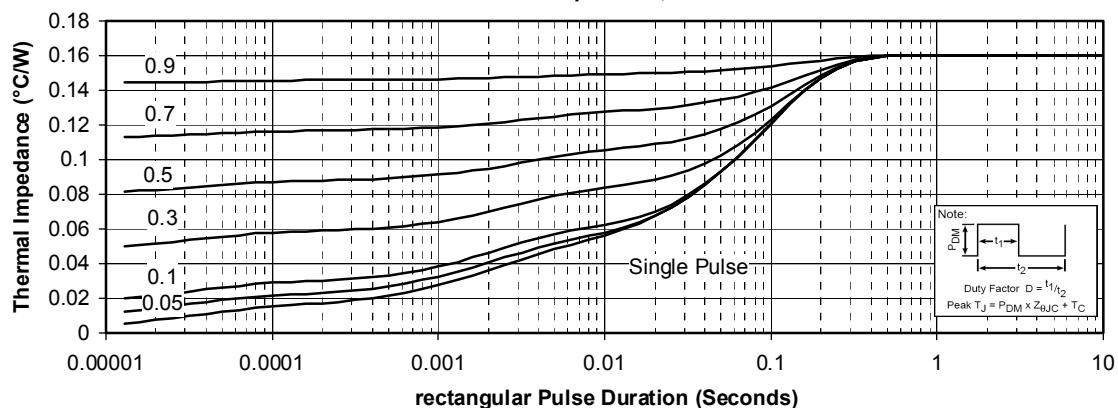


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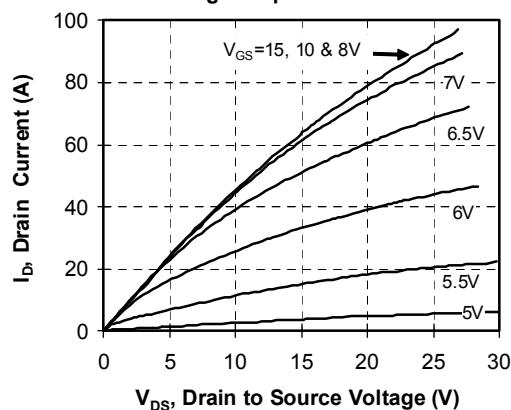
**APTM120DU29TG**

## Typical Performance Curve

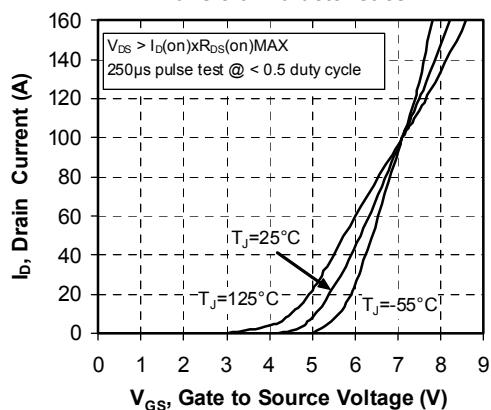
Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



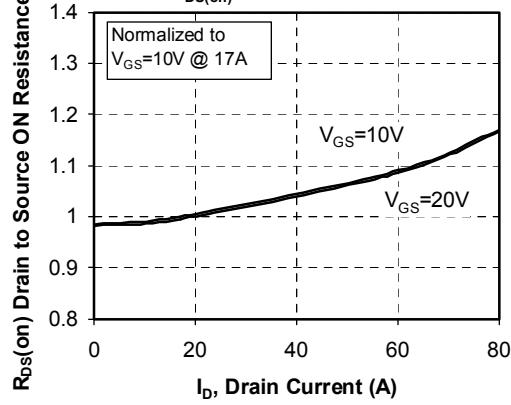
Low Voltage Output Characteristics



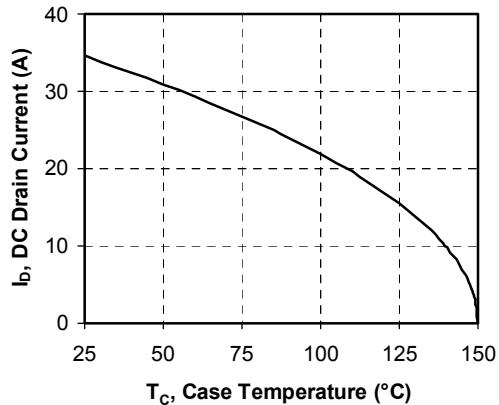
Transfert Characteristics



$R_{DS(on)}$  vs Drain Current



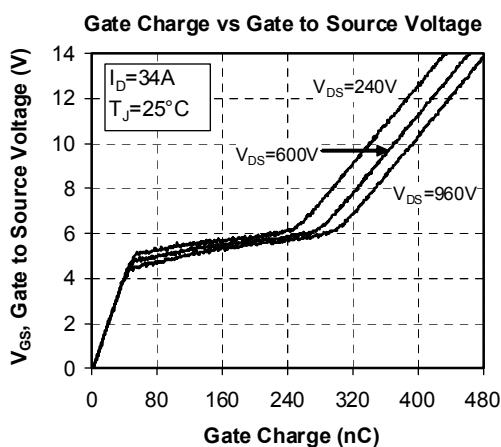
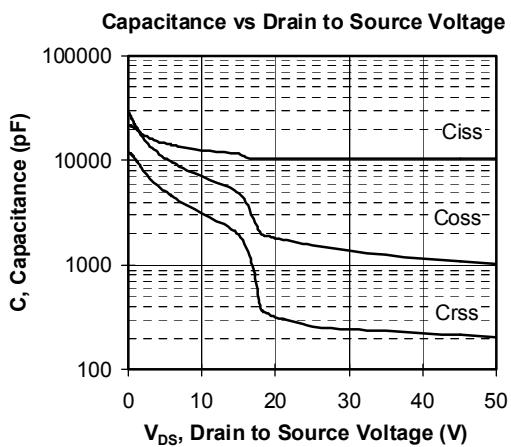
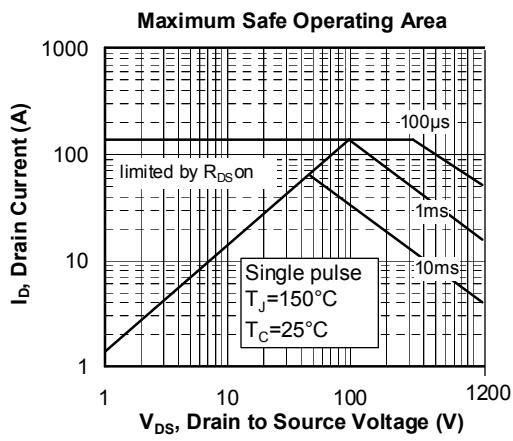
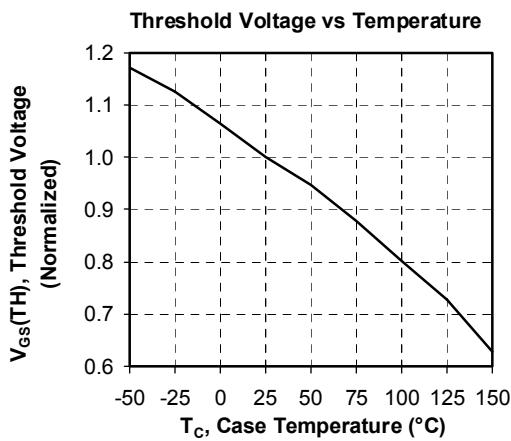
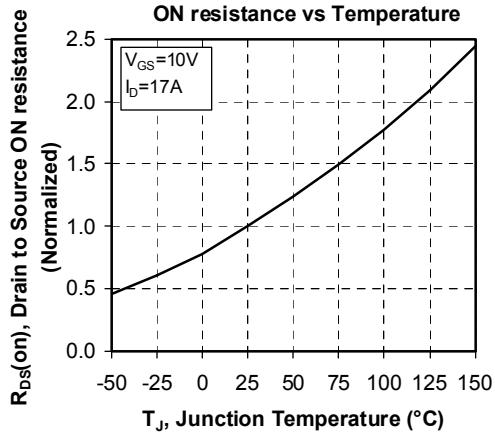
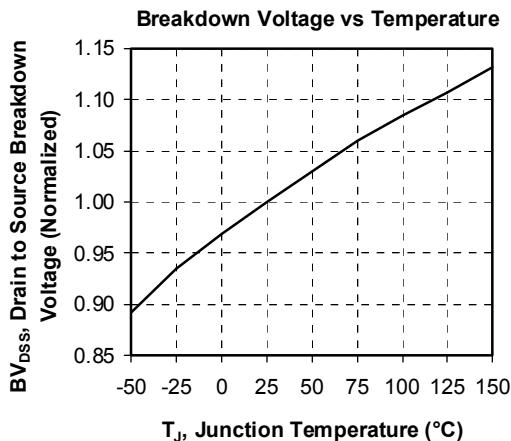
DC Drain Current vs Case Temperature





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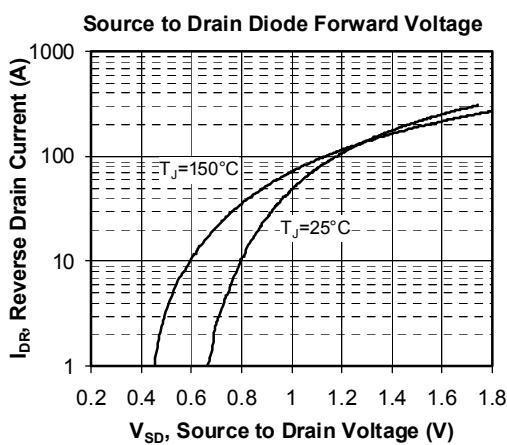
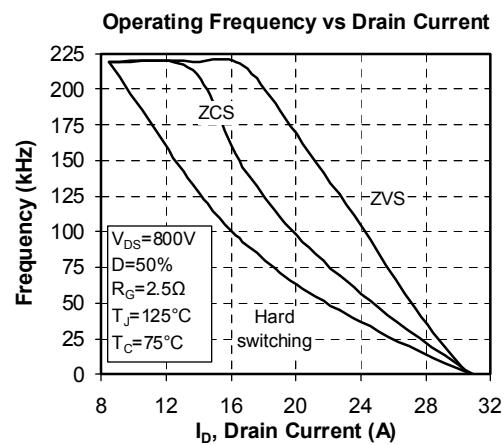
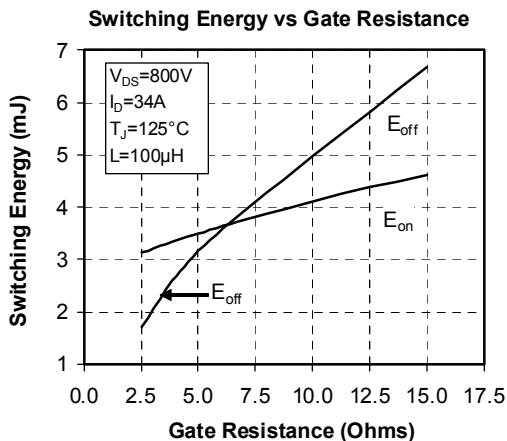
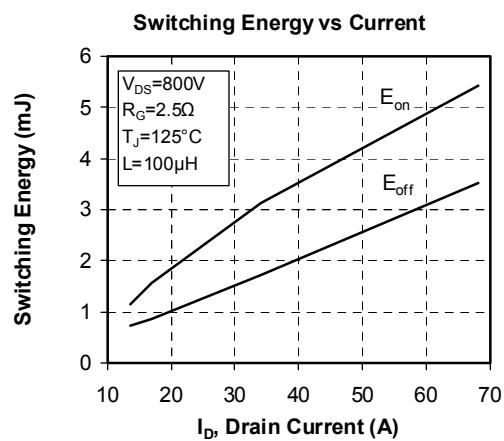
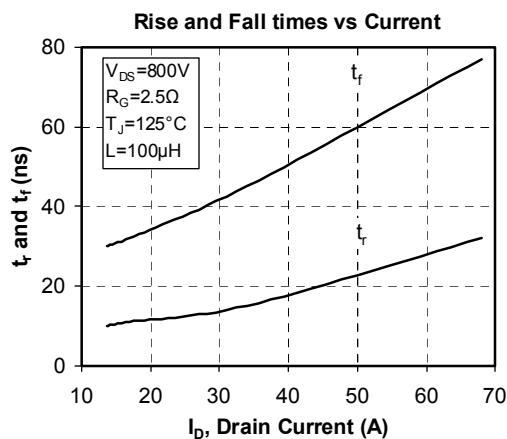
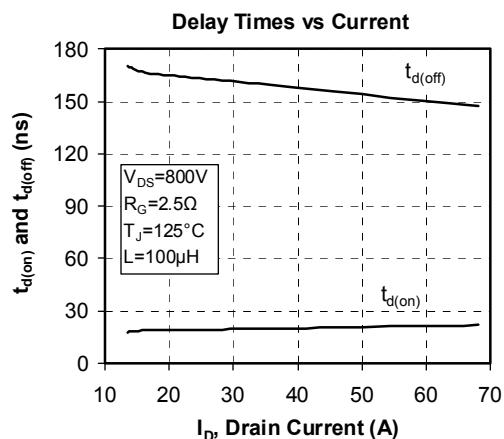
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Microsemi reserves the right to change, without notice, the specifications and information contained herein

Microsemi's products are covered by one or more of U.S patents 4,895,810 5,045,903 5,089,434 5,182,234 5,019,522 5,262,336 6,503,786 5,256,583 4,748,103 5,283,202 5,231,474 5,434,095 5,528,058 and foreign patents. U.S and Foreign patents pending. All Rights Reserved.